

Search Notes



Application/Control No.

10/783,022

Examiner

Hwei-Siu C. Payer

Applicant(s)/Patent under Reexamination

SHIRAISHI ET AL.

Art Unit

3724

SEARCHED

Class	Subclass	Date	Examiner
030	90.1	11-2-05	Payer
	91.2		
	94		
	123		
	253		
	234		
	345		
	90.4		
	90.6		
	279.2		
	278		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
text search (see search history printout)	11-2-05	Payer